

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/519,204	<b>Applicant(s)/Patent under Reexamination</b> CHANG ET AL.
<b>Examiner</b> Jerry T. Rahill	<b>Art Unit</b> 2874	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner